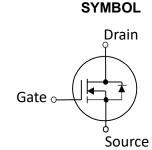


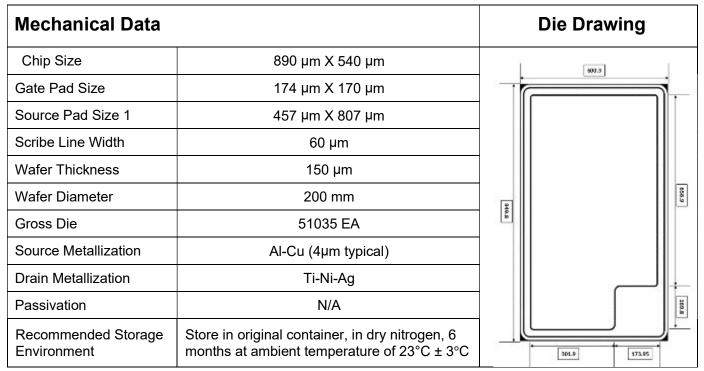
## 30V, 5.8A <sup>(1)</sup> N-Channel MOSFET

- Proprietary Trench Gate Device Design and Processes
- High Reliability Capability
- Sampled CP Probing and Inking



## Electrical Characteristics in C/P Test (T<sub>J</sub> at 25 °C)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Condition
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	30	—		V	V <sub>GS</sub> =0V, I <sub>D</sub> =250µA
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance		14	19	mΩ	$V_{GS} = 10V, I_{D} = 1A(2)$
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	—	25	29	mΩ	$V_{GS} = 4.5V, I_{D} = 1A(2)$
V <sub>GS (th)</sub>	Gate Threshold Voltage	1.0	—	2.5	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250µA
I <sub>DSS</sub>	Drain-to-Source Leakage Current	—	—	1	μA	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V
I <sub>GSS</sub>	Gate-to-Source Leakage Current	-100	—	100	nA	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature	-55°C to 150°C Max.				



(1) This characteristic assumes the die is assembled in SOP-8 package. Actual performance may degrade when assembled.

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(2) Pulse Width tp = < 1 mS, Duty Cycle < 2%.



Specific Assembly Info	Die Drawing		
Package Type	SOP-8		
Die Attach Method	Soft solder		
Soft Solder Composition	Pb,Sn,Ag		
Gate Wire Bonding	Cu, 2 mil x1	8000	
Source Wire Bonding	Cu, 2 mil x8		
Molding Compound Manufacturer	G700HF		
Solder Plating Composition	Pure Tin	101.8	

Position		Bonding Diagram Top View		
	X (um)	Y (um)	ZERO	
ZERO	0	0		
ТОР	889.8	540.3		
S1	41.6	41.6		
S2	697.375	498.7		
S3	848.2	343.55		
G1	703.375	349.75	2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2	
G2	873.2	523.7		

-2-



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Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Condition
I <sub>DSS</sub>	Drain-to-Source Leakage Current			1	μA	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V
I <sub>GSSF</sub>	Gate-to-Source Leakage Current			100	nA	V <sub>DS</sub> =0V, V <sub>GS</sub> =+20V
I <sub>GSSR</sub>	Gate-to-Source Leakage Current	-100	—		nA	V <sub>DS</sub> =0V, V <sub>GS</sub> =-20V
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	30	_		V	V <sub>GS</sub> =0V, I <sub>D</sub> =250µA
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	30	_		V	$V_{GS}$ =0V, I <sub>D</sub> =1mA
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance		_	25	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =5A
V <sub>GS (th)</sub>	Gate Threshold Voltage	1.0	_	2.5	V	$V_{DS}$ = $V_{GS}$ , $I_D$ =250 $\mu$ A
V <sub>SD</sub>	Drain-Source Diode Forward Voltage			1.1	V	$V_{GS}$ = 0V, $I_{SD}$ = 5A
EAS test	IAS				А	VDD=30V,Vgs=10V, RG=25ohm,L=0.5mH
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature	-55°C to 150°C Max.				



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